

10/519577

DT1 Rec'd PCT/PTO 27 DEC 2004

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re U.S. Patent Application of:

INVENTORS: LEVNER et al.

SERIAL NO.: 11/

FILED: Herewith

TITLE: "Methods And Apparatus for Detecting Multiple Optical Wave Lengths"

ATTORNEY DOCKET NO.: 904.0102.U1(US)

ART UNIT: Unknown

EXAMINER: Unknown

Mail Stop  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

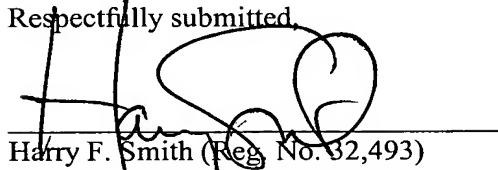
INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Pursuant to Sections 609 and 707.05(b) of the MPEP and 37 CFR 1.97-1.99, the attached form PTO-1449 lists a document, which may be pertinent to the invention as claimed in the above-identified application. Copy of the document is herewith submitted.

The citation of this document should not be construed as a representation that a thorough search has been made, or that other, more pertinent material is not available.

Respectfully submitted,



Harry F. Smith (Reg. No. 32,493)  
HARRINGTON & SMITH, LLP  
4 Research Drive  
Shelton, CT 06484-6212  
Telephone: (203) 925-9400  
Facsimile: (203) 944-0245  
Customer No.: 29,683

**INFORMATION DISCLOSURE  
CITATION FORM FOR  
PATENT APPLICATION  
(FORM PTO-1449)  
(Substitute)**

Docket No.: 904.0102.U1(US)

Serial No.: Unknown

**10/519577**

Applicant(s): Levner et al.

Filing Date: Herewith

Group: Unknown

**U.S. PATENT DOCUMENTS**

Examiner Initials	Document Number (Number-Kind Code)	Publication Date (MM-DD-YYYY)	Name of Patentee or Applicant	Class	Sub-class

**FOREIGN PATENT DOCUMENTS**

Examiner Initials	Document Number (Country Code-Number-Kind Code)	Publication Date (MM-DD-YYYY)	Name Of Patentee of Applicant	Translation? Yes/No/n/a

**OTHER DOCUMENTS (Author (Capitalize), Title, Date, Pages, Etc., if known)**

	AVRUTSKY, I.A. et al., "Design of Widely Tunable Semiconductor Lasers and the Concept of Binary Superimposed Gratings (BSG's)", April 1998, Pages 729-741, Volume 34, Issue: 4, IEEE Journal of Quantum Electronics

Examiner's Signature:

Date Considered:

Initial if reference was considered, whether or not citation is in conformance with MPEP. Mark through citation if not considered.  
Include a copy of this citation form with your next correspondence to the Applicant(s).